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- 3-State Outputs Drive Bus Lines or Buffer Memory Address Registers
- pnp Inputs Reduce dc Loading
- Package Options Include Plastic Small-Outline (DW) Packages, Ceramic Chip Carriers (FK), and Standard Plastic (N) and Ceramic (J) 300-mil DIPs

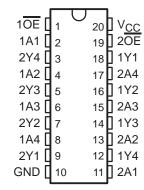
description

These octal buffers and line drivers are designed specifically to improve the performance and density of 3-state memory address drivers, clock drivers, and bus-oriented receivers and transmitters. With the 'ALS240A, 'ALS241C, 'AS240A, SN54AS241, and SN74AS241A, these devices provide the choice of selected combinations of inverting outputs, symmetrical active-low output-enable (\overline{OE}) inputs, and complementary OE and \overline{OE} inputs.

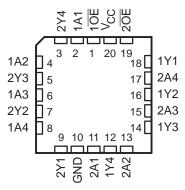
The -1 version of SN74ALS244C is identical to the standard version, except that the recommended maximum I_{OL} of the -1 version is 48 mA. There is no -1 version of the SN54ALS244C.

The SN54ALS244C and SN54AS244 are characterized for operation over the full military temperature range of -55°C to 125°C. The SN74ALS244C and SN74AS244A are characterized for operation from 0°C to 70°C.

SN54ALS244C, SN54AS244 . . . J PACKAGE SN74ALS244C, SN74AS244A . . . DW OR N PACKAGE (TOP VIEW)



SN54ALS244C, SN54AS244 . . . FK PACKAGE (TOP VIEW)

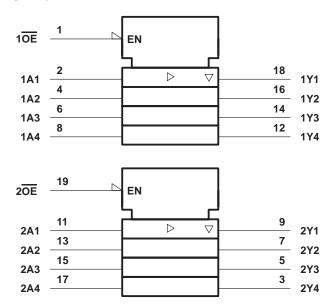


FUNCTION TABLE (each buffer)

INP	JTS	OUTPUT
ŌĒ	Α	Υ
L	Н	Н
L	L	L
Н	Χ	Z

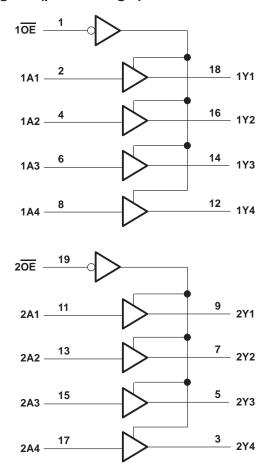
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logic symbol†



[†] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

logic diagram (positive logic)



absolute maximum ratings over operating free-air temperature range (unless otherwise noted)‡

Supply voltage, V _{CC}	7 V
Input voltage, V _I	7 V
Voltage applied to a disabled 3-state output	5.5 V
Operating free-air temperature range, T _A : SN54ALS244C	55°C to 125°C
SN74ALS244C	0°C to 70°C
Storage temperature range	−65°C to 150°C

[‡] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.



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recommended operating conditions

		SN54ALS244C		4C	SN74ALS244C			UNIT	
		MIN	NOM	MAX	MIN	NOM	MAX	UNIT	
VCC	Supply voltage	4.5	5	5.5	4.5	5	5.5	V	
VIH	High-level input voltage	2			2			V	
V. Laurianalianutus	Low-level input voltage			0.8†			0.8	V	
VIL	Low-level input voitage			0.7‡				V	
ІОН	High-level output current			-12			-15	mA	
lo.	Low lovel output ourropt			12			24	mA	
IOL L	Low-level output current						48§	7 '''A	
TA	Operating free-air temperature	-55		125	0		70	°C	

[†] Applies over temperature range –55°C to 70°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST (CONDITIONS	SN54ALS244C		SN74ALS244C			UNIT	
PARAMETER	1531 (CONDITIONS	MIN	TYP¶	MAX	MIN	TYP¶	MAX	UNII
VIK	$V_{CC} = 4.5 \text{ V},$	$I_{I} = -18 \text{ mA}$			-1.5			-1.5	V
	V _{CC} = 4.5 V to 5.5 V	$I_{OH} = -0.4 \text{ mA}$	V _{CC} -2	2		VCC -2	2		
Va.,	VCC = 4.5 V to 5.5 V	$I_{OH} = -3 \text{ mA}$	2.4	3.2		2.4	3.2		V
VOH	V _{CC} = 4.5 V	$I_{OH} = -12 \text{ mA}$	2						V
	vCC = 4.5 v	$I_{OH} = -15 \text{ mA}$				2			
		I _{OL} = 12 mA		0.25	0.4		0.25	0.4	
V_{OL}	V _{CC} = 4.5 V	I _{OL} = 24 mA					0.35	0.5	V
		I _{OL} = 48 mA (-1 version)					0.35	0.5	
lozh	$V_{CC} = 5.5 \text{ V},$	V _O = 2.7 V			20			20	μΑ
lozL	$V_{CC} = 5.5 \text{ V},$	V _O = 0.4 V			-20			-20	μΑ
lj	$V_{CC} = 5.5 \text{ V},$	V _I = 7 V			0.1			0.1	mA
lіН	$V_{CC} = 5.5 \text{ V},$	V _I = 2.7 V			20			20	μΑ
I _{IL}	V _{CC} = 5.5 V,	V _I = 0.4 V			-0.1			-0.1	mA
IO [#]	V _{CC} = 5.5 V,	V _O = 2.25 V	-20		-112	-30		-112	mA
		Outputs high		9	15		9	17	
ICC	V _{CC} = 5.5 V	Outputs low		15	24		15	24	mA
		Outputs disabled		17	27		17	27	



[‡] Applies over temperature range 70°C to 125°C

[§] Applies only to the -1 version and only if V_{CC} is between 4.75 V and 5.25 V

[¶] All typical values are at V_{CC} = 5 V, T_A = 25°C.

The output conditions have been chosen to produce a current that closely approximates one half of the true short-circuit output current, los.

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switching characteristics (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	C _L R1 R2	_ = 50 pF = 500	2,	,	UNIT
			SN54AL	S244C	SN74AL		
			MIN	MAX	MIN	MAX	
t _{PLH}	А	V	1	16	2	10	ns
t _{PHL}		Y	3	12	3	10	115
^t PZH	ŌĒ	V	1	26	3	20	ns
tPZL	OE	Y	1	24	3	20	115
[†] PHZ	ŌĒ	Y	2	10	2	10	ns
^t PLZ	OE .	I I	1	26	1	13	115

[†] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)‡

Supply voltage, V _{CC}	7 V
Input voltage, V _I	7 V
Voltage applied to a disabled 3-state output	
Operating free-air temperature range, T _A : SN54AS244	-55°C to 125°C
SN74AS244A	0°C to 70°C
Storage temperature range	-65°C to 150°C

[‡] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

recommended operating conditions

		SI	N54AS24	4	SN74AS244A		UNIT	
		MIN	NOM	MAX	MIN	NOM	MAX	UNII
Vcc	Supply voltage	4.5	5	5.5	4.5	5	5.5	V
VIH	High-level input voltage	2			2			V
V _{IL}	Low-level input voltage			0.8			0.8	V
IOH	High-level output current			-12			-15	mA
lOL	Low-level output current			48			64	mA
TA	Operating free-air temperature	-55		125	0		70	°C

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electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

DADAMETED	TEST CONDITIONS		SN	54AS24	14	SN7	UNIT			
PARAMETER	lESI CC	TEST CONDITIONS		TYP [†]	MAX	MIN	TYP [†]	MAX	ONLI	
VIK	V _{CC} = 4.5 V,	$I_{I} = -18 \text{ mA}$			-1.2			-1.2	V	
	$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V},$	$I_{OH} = -2 \text{ mA}$	V _{CC} -2			V _{CC} -2				
Val		$I_{OH} = -3 \text{ mA}$	2.4	3.4		2.4	3.4		V	
VOH	V _{CC} = 4.5 V	$I_{OH} = -12 \text{ mA}$	2.4						v	
		$I_{OH} = -15 \text{ mA}$				2.4				
Vol	V _{CC} = 4.5 V	$I_{OL} = 48 \text{ mA}$			0.55				V	
VOL	VCC = 4.5 V	$I_{OL} = 64 \text{ mA}$						0.55	v	
lozh	$V_{CC} = 5.5 \text{ V},$	$V_0 = 2.7 \text{ V}$			50			50	μΑ	
I _{OZL}	$V_{CC} = 5.5 \text{ V},$	$V_0 = 0.4 V$			-50			-50	μΑ	
lį	$V_{CC} = 5.5 \text{ V},$	V _I = 7 V			0.1			0.1	mA	
lн	$V_{CC} = 5.5 \text{ V},$	V _I = 2.7 V			20			20	μΑ	
OE OE	V _{CC} = 5.5 V,	V _I = 0.4 V			-0.5			-0.5	mA	
I _{IL} A	VCC = 3.5 v,	5.5 v, v = 0.4 v		-1				-1	IIIA	
10 [‡]	V _{CC} = 5.5 V,	V _O = 2.25 V	-50		-150	-50		-150	mA	
		Outputs high		22	34		22	34		
Icc	V _{CC} = 5.5 V	Outputs low		60	90		60	90	mA	
		Outputs disabled		34	54		34	54		

switching characteristics (see Figure 1)

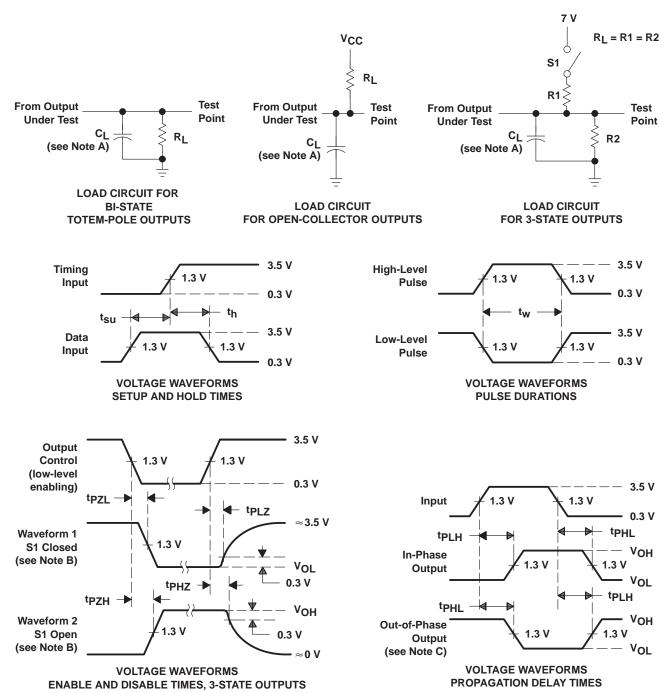
PARAMETER	FROM (INPUT)	TO (OUTPUT)	C R R	L = 50 1 = 500 2 = 500 A = MIN	Ω,	§	UNIT
			MIN	MAX	MIN	MAX	
tpLH	А	٧	2	9	2	6.2	ns
t _{PHL}		Y	2	7	1	6.2	115
^t PZH	<u></u>	Υ	2	10	1	9	ns
t _{PZL}	ŌĒ	Y	2	8	2	7.5	113
^t PHZ	ŌĒ	٧	2	6.5	1	6	ns
tPLZ	OL .	ľ	2	10.5	1	9	113

[§] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.



[†] All typical values are at V_{CC} = 5 V, T_A = 25°C. ‡ The output conditions have been chosen to produce a current that closely approximates one half of the true short-circuit output current, I_{OS}.

PARAMETER MEASUREMENT INFORMATION SERIES 54ALS/74ALS AND 54AS/74AS DEVICES



NOTES: A. C_L includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. When measuring propagation delay items of 3-state outputs, switch S1 is open.
- D. All input pulses have the following characteristics: PRR \leq 1 MHz, $t_f = t_f = 2$ ns, duty cycle = 50%.
- E. The outputs are measured one at a time with one transition per measurement.

Figure 1. Load Circuits and Voltage Waveforms



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